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ON Semiconductor®

FDME820NZT

N-Channel PowerTrench[®] MOSFET 20 V, 9 A, 18 m Ω

Features

- Max $r_{DS(on)}$ = 18 m Ω at V_{GS} = 4.5 V, I_D = 9 A
- Max $r_{DS(on)}$ = 24 m Ω at V_{GS} = 2.5 V, I_D = 7.5 A
- Max $r_{DS(on)} = 32 \text{ m}\Omega$ at $V_{GS} = 1.8 \text{ V}$, $I_D = 7 \text{ A}$
- Low profile: 0.55 mm maximum in the new package MicroFET 1.6x1.6 **Thin**
- Free from halogenated compounds and antimony oxides
- HBM ESD protection level >2.5 kV (Note3)
- RoHS Compliant

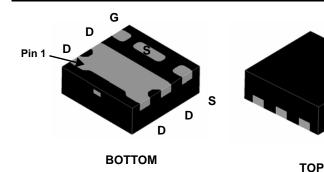


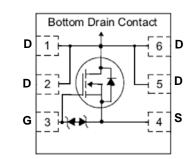
General Description

This Single N-Channel MOSFET has been designed using ON Semiconductor's advanced Power Trench process to optimize the $r_{DS(ON)}$ @ VGS = 1.8 V on special MicroFET leadframe.

Applications

- Li-Ion Battery Pack
- Baseband Switch
- Load Switch
- DC-DC Conversion





MicroFET 1.6x1.6 Thin

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Paramet		Ratings	Units	
V _{DS}	Drain to Source Voltage			20	V
V_{GS}	Gate to Source Voltage			±12	V
	Drain Current -Continuous	T _A = 25 °C	(Note 1a)	9	۸
'D	-Pulsed			40	A
В	Power Dissipation for Single Operation	T _A = 25 °C	(Note 1a)	2.1	W
P_{D}	Power Dissipation for Single Operation $T_A = 25 ^{\circ}\text{C}$ (Note 1b)			0.7	VV
T _J , T _{STG}	Operating and Storage Junction Temperate		-55 to +150	°C	

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	70	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	190	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
8T	FDME820NZT	MicroFET 1.6x1.6 Thin	7 "	8 mm	5000 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Symbol	Parameter Test Conditions		Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	20			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		20		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 16 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μΑ

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250 \mu A$	0.5	0.8	1.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		-3		mV/°C
	Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 9 \text{ A}$		14	18	mΩ
		$V_{GS} = 2.5 \text{ V}, I_D = 7.5 \text{ A}$		17	24	
r _{DS(on)}		$V_{GS} = 1.8 \text{ V}, I_D = 7 \text{ A}$		26	32	
		$V_{GS} = 4.5 \text{ V}, I_D = 9 \text{ A},$ $T_J = 125 ^{\circ}\text{C}$		19	24	

Dynamic Characteristics

C _{iss}	Input Capacitance	V 40.V V 0.V	865	pF
C _{oss}	Output Capacitance	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz	203	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 101112	190	pF
R _n	Gate Resistance		1.0	Ω

Switching Characteristics

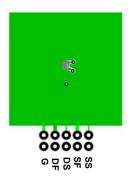
t _{d(on)}	Turn-On Delay Time		9	ns
t _r	Rise Time	V _{DD} = 10 V, I _D = 4 A	5	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 4.5 \text{ V}, R_{GEN} = 2 \Omega$	19	ns
t _f	Fall Time		5	ns
Qg	Total Gate Charge	$V_{DD} = 4.2 \text{ V}, I_D = 3 \text{ A}, V_{GS} = 4.3 \text{ V}$	8.0	nC
Qg	Total Gate Charge	$V_{DD} = 4.2 \text{ V}, I_D = 3 \text{ A}, V_{GS} = 4.5 \text{ V}$	8.5	nC
Q _{gs}	Gate to Source Gate Charge	V 40.V I 0.A	1.4	nC
Q _{gd}	Gate to Drain "Miller" Charge	V _{DD} = 10 V, I _D = 9 A	3.2	nC

Drain-Source Diode Characteristics

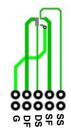
V _{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 1.6 \text{ A}$	(Note 2)	0.7	1.2	V
		$V_{GS} = 0 \text{ V}, I_{S} = 9 \text{ A}$	(Note 2)	8.0	1.2	V
t _{rr}	Reverse Recovery Time	IF = 9 A. di/dt = 100 A/us		18		ns
Q _{rr}	Reverse Recovery Charge	IF = 9 A, di/dt = 100 A/ds		4		nC

Notes

^{1.} R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



 a. 70 °C/W when mounted on a 1 in² pad of 2 oz copper.



b. 190 °C/W when mounted on a minimum pad of 2 oz copper.

^{2.} Pulse Test: Pulse Width < 300 $\mu s,\,$ Duty cycle < 2.0%.

^{3.} The diode connected between the gate and source serves only as protection ESD. No gate overvoltage rating is implied.

Typical Characteristics T_J = 25 °C unless otherwise noted

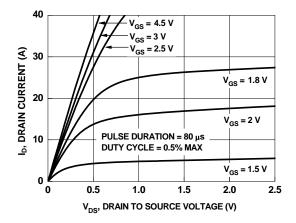


Figure 1. On Region Characteristics

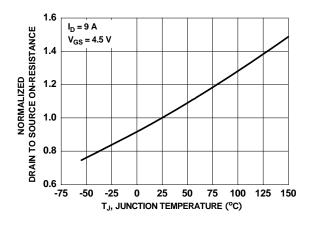


Figure 3. Normalized On Resistance vs Junction Temperature

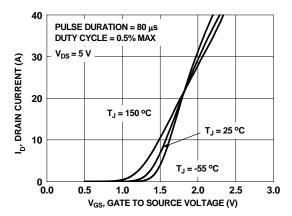


Figure 5. Transfer Characteristics

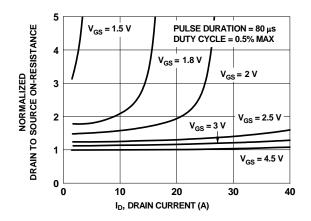


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

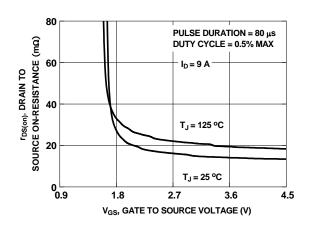


Figure 4. On-Resistance vs Gate to Source Voltage

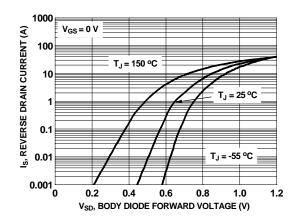


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

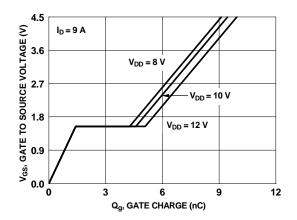


Figure 7. Gate Charge Characteristics

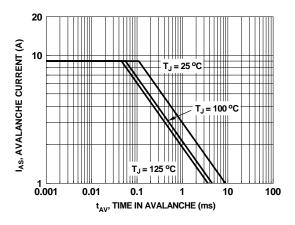


Figure 9. Unclamped Inductive Switching Capability

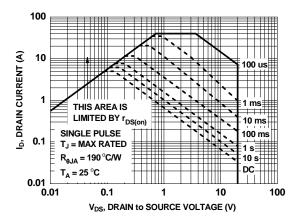


Figure 11. Forward Bias Safe Operating Area

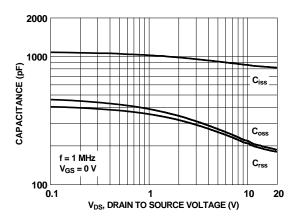


Figure 8. Capacitance vs Drain to Source Voltage

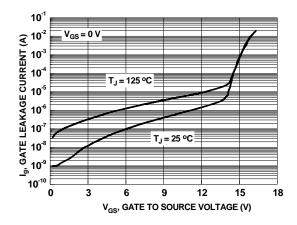


Figure 10. Gate Leakage Current vs Gate to Source Voltage

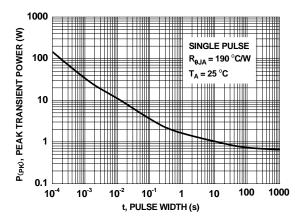


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25 °C unless otherwise noted

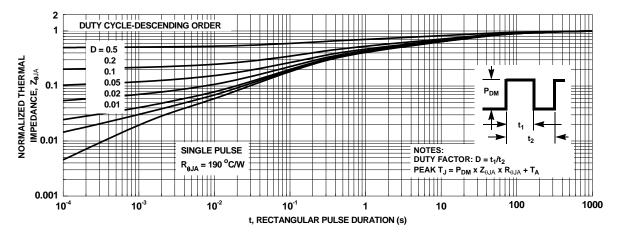
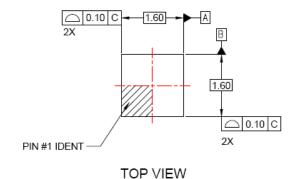
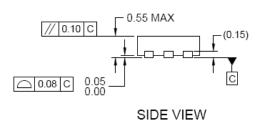
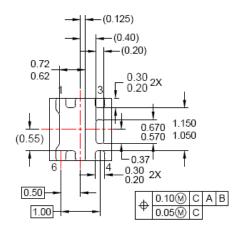


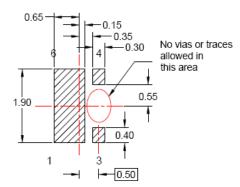
Figure 13. Junction-to-Ambient Transient Thermal Response Curve

Dimensional Outline and Pad Layout

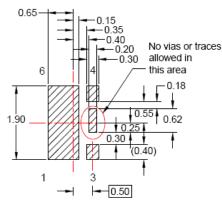








RECOMMENDED LAND PATTERN OPT 1



RECOMMENDED LAND PATTERN OPT 2

NOTES:

- A. DOES NOT FULLY CONFORM TO JEDEC REGISTRATION
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994.
- D. LAND PATTERN RECOMMENDATION IS BASED ON FSC DESIGN ONLY

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